

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/749,356	AHN ET AL.
	Examiner	Art Unit
	Tan T. Nguyen	2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	149	9/9/2005	TNT
365	185.08	9/9/2005	TNT
365	185.18	9/9/2005	TNT